Notice of References Cited

Application/Control No. 09/973,046	Applicant(s)/Patent Under Reexamination JUNG, SOON-HO		
Examiner	Art Unit		
BINH K. TIEU	2614	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,968,365	11-2005	Hollstrom et al.	709/217
*	В	US-2002/0082057	06-2002	Kim, Hyoung Yoon	455/568
*	С	US-2005/0153729	07-2005	Logan et al.	455/550.1
*	D	US-2002/0187749	12-2002	Beasley et al.	455/41
*	E	US-2005/0094571	05-2005	Lempio et al.	370/252
*	F	US-2005/003 <u>7</u> 779	02-2005	Ma et al.	455/456.6
*	G	US-2003/0050058	03-2003	Walsh et al.	455/426
*	Н	US-6,725,022	04-2004	Clayton et al.	455/154.1
*	ı	US-6,876,661	04-2005	Asai, Takayuki	370/401
*	J	US-5,694,549	12-1997	Carlin et al.	709/250
*	К	US-6,349,409	02-2002	Chan, Hark C.	725/105
	L	US-			
	М	US-			· · · · · · · · · · · · · · · · · · ·

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 01/41483 A1	07-2001	INTERNATIONAL	HOLLSTROM et al.	H04Q 7/32
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U		
	v		
	w		
	х		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.